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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/206,027	12/04/1998	BARNEY M. COHEN	AMAT/3049/MD	4950	
75	90 07/23/2002				
APPLIED MATERIALS INC			EXAMINER		
PATENT COU P O BOX 450 A	1		VINH, LAN		
SANTA CLAR	A, CA 95052		ART UNIT	PAPER NUMBER	
			1765	25	
			DATE MAILED: 07/23/2002	V >	

Please find below and/or attached an Office communication concerning this application or proceeding.

			-1VIF=20
	Application No.	Applicant(s)	
Advisory Action	09/206,027	COHEN ET AL.	
Advisory Action	Examiner	Art Unit	
	Lan Vinh	1765	
The MAILING DATE of this communication a	ppears on the cover sheet v	vith the correspondence add	Iress
THE REPLY FILED 16 July 2002 FAILS TO PLACE Therefore, further action by the applicant is required final rejection under 37 CFR 1.113 may only be eithe condition for allowance; (2) a timely filed Notice of Alexamination (RCE) in compliance with 37 CFR 1.114	to avoid abandonment of ther: (1) a timely filed amendr ppeal (with appeal fee); or	nis application. A proper re ment which places the appli	cation in
	REPLY (check either a) or	r b)]	
a) The period for reply expiresmonths from the main	iling date of the final rejection.		ania latan In ma
b) The period for reply expires on: (1) the mailing date of this event, however, will the statutory period for reply expire late ONLY CHECK THIS BOX WHEN THE FIRST REPLY V 706.07(f). Extensions of time may be obtained under 37 CFR 1.136(a). The nave been filed is the date for purposes of determining the period of 637 CFR 1.17(a) is calculated from: (1) the expiration date of the short (b) above, if checked. Any reply received by the Office later than three	ter than SIX MONTHS from the ma WAS FILED WITHIN TWO MONT he date on which the petition under extension and the corresponding an tened statutory period for reply origi	illing date of the final rejection. HS OF THE FINAL REJECTION. 37 CFR 1.136(a) and the appropriat end in the second count of the fee. The appropriate endingly set in the final Office action; or	See MPEP te extension fee tension fee under r (2) as set forth in
earned patent term adjustment. See 37 CFR 1.704(b).	se months after the maining date of		,,
1. A Notice of Appeal was filed on Appell 37 CFR 1.192(a), or any extension thereof (37	ant's Brief must be filed wi CFR 1.191(d)), to avoid d	thin the period set forth in ismissal of the appeal.	į
2. The proposed amendment(s) will not be entered	ed because:		
(a) they raise new issues that would require f	urther consideration and/or	search (see NOTE below);	
(b) they raise the issue of new matter (see N			
(c) they are not deemed to place the applicat issues for appeal; and/or	tion in better form for appea	al by materially reducing or	simplifying the
(d) they present additional claims without ca	nceling a corresponding nu	ımber of finally rejected cla	ims.
3. Applicant's reply has overcome the following r	ejection(s):		
4. Newly proposed or amended claim(s) w canceling the non-allowable claim(s).	ould be allowable if submit	ted in a separate, timely file	ed amendment
5.⊠ The a) affidavit, b) exhibit, or c) reque application in condition for allowance because	st for reconsideration has t e: <u>See attachment</u> .	peen considered but does N	OT place the
6. The affidavit or exhibit will NOT be considered raised by the Examiner in the final rejection.	d because it is not directed	SOLELY to issues which w	ere newly
7. For purposes of Appeal, the proposed amenda explanation of how the new or amended claim	ment(s) a) will not be entended in the months would be rejected is pro-	tered or b)⊠ will be entered vided below or appended.	d and an
The status of the claim(s) is (or will be) as foll	ows:		
Claim(s) allowed:			
Claim(s) objected to:			
Claim(s) rejected: <u>1, 3-8, 10-40</u> .			
Claim(s) withdrawn from consideration:			
8. The proposed drawing correction filed on	is a) approved or b)	disapproved by the Exa	miner.
9. Note the attached Information Disclosure State	tement(s)(PTO-1449) Pap	er No(s)	
10. Other:			

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Response to Arguments

1. Applicant's arguments filed 7/16/2002 have been fully considered but they are not persuasive.

In traversing the examiner's position that the evidence of nonobviousness (Fig. 4 in the specification) does not commensurate in scope with claims 8, 14, 31, 36, the applicants argue that Fig. 4 shows that the etch rate increases as the volume of argon decreased from 75% by volume to 25% by volume while the volume of helium is increased as shown in page 9 of the specification. Upon reviewing Fig. 4 and page 9 of the specification as well as the recited claim language of claims 8, 14, 31, 36, the examiner disagrees with the applicants. Claims 8, 14, 31, 36 recite the language of "increasing the helium content of the plasma to increase etching....the gas mixture comprises less than about 75% by volume of Ar". Fig. 4 and page 9 of the specification shows that the etch rate improves/increases until the argon volume is reduced to 25% by volume while the volume of helium increased because the plasma mixture consisting of 25% of Ar, 5% of hydrogen and helium. However, the examiner notes that Fig. 4 also shows that when the Ar volume is reduced to 40% by volume (less than about 75%) although the volume of helium increases, the etch rate decreased. Hence, the examiner asserts that evidence of nonobviousness (Fig. 4 in the specification) does not commensurate in scope with claims 8, 14, 31, 36.

It is argued that the Guinn reference has not provided as to which parameters are result-effective variable. This argument is not found persuasive because as recited in col 4, lines 3-6 of Guinn Guinn teaches that wherein a discrete processing parameter (

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temperature, flow rate, pressure) is varied to change the etch rate. Varying a processing parameter such as a flow rate to change the etch rate certainly reads on using the flow rate/parametes as a result-effective variable.

The applicants also argue that the Examiner has mistakenly taken Kennard 's teaching of "adding a flow volume of helium to a plasma etching gas mixture" to be teaching of "increasing a flow volume of helium to a plasma etching mixture". The examiner disagrees because since Kennard discloses adding a high flow of helium (greater than about 65 % of the total volume) to a gas mixture (col 3, lines 57-58), adding a high flow of helium (greater than about 65 % of the total volume) to a gas mixture reads on increasing a flow volume of helium to a gas mixture.

Conclusion

Any inquiry concerning this communication or earlier communications from the 2. examiner should be directed to Lan Vinh whose telephone number is 703 305-6302. The examiner can normally be reached on M-F 8:30-5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Benjamin Utech can be reached on 703 308-3836. The fax phone numbers for the organization where this application or proceeding is assigned are 703 872-9310 for regular communications and 703 872-9311 for After Final communications.

July 21, 2002

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